

# J337-TL-E-VB Datasheet P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY     |                                    |   |       |  |  |  |
|---------------------|------------------------------------|---|-------|--|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}\left(\Omega\right)$    | I <sub>D</sub> (A) <sup>d</sup> Q <sub>g</sub> (Typ.) |       |  |  |  |
| - 30                | 0.033 at V <sub>GS</sub> = - 10 V  | - 38  | 19 nC |  |  |  |
| - 30                | 0.046 at V <sub>GS</sub> = - 4.5 V | - 25  | 19110 |  |  |  |

#### **FEATURES**

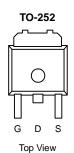
- Halogen-free
- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

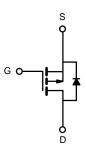


ROHS

## **APPLICATIONS**

- Load Switch
- · Notebook Adaptor Switch





P-Channel MOSFET

| Parameter   | Symbol                            | Limit           | Unit                   |     |
|---|-----------------------------------|-----------------|------------------------|-----|
| Drain-Source Voltage                                |                                   | V <sub>DS</sub> | - 30                   | V   |
| Gate-Source Voltage                                 |                                   | V <sub>GS</sub> | ± 20                   | v   |
|   | T <sub>C</sub> = 25 °C            |                 | - 38                   |     |
| Continuous Drain Current (T <sub>.I</sub> = 150 °C) | T <sub>C</sub> = 70 °C            |                 | - 25                   |     |
| Continuous Diam Curient (1) = 130 °C)               | T <sub>A</sub> = 25 °C            | l <sub>D</sub>  | - 14.9 <sup>a, b</sup> |     |
|   | T <sub>A</sub> = 70 °C            |                 | - 13.6 <sup>a, b</sup> |     |
| Pulsed Drain Current                                | I <sub>DM</sub>                   | - 112           | A                      |     |
| Continuous Source-Drain Diode Current               | T <sub>C</sub> = 25 °C            | I.              | - 4.1                  |     |
| Continuous Source-Drain Diode Current               | T <sub>A</sub> = 25 °C            | l <sub>s</sub>  | - 2.2 <sup>a, b</sup>  |     |
| Avalanche Current                                   | 1 0411                            | I <sub>AS</sub> | - 20                   |     |
| Single-Pulse Avalanche Energy                       | L = 0.1 mH                        | E <sub>AS</sub> | 20                     | mJ  |
|   | T <sub>C</sub> = 25 °C            |                 | 25                     |     |
| Manianum Danian Disain ation                        | T <sub>C</sub> = 70 °C            |                 | 20                     | 14/ |
| Maximum Power Dissipation                           | T <sub>A</sub> = 25 °C            | P <sub>D</sub>  | 2.7 <sup>a, b</sup>    | W   |
|   | T <sub>A</sub> = 70 °C            |                 | 1.7 <sup>a, b</sup>    |     |
| Operating Junction and Storage Temperature Range    | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150     | °C                     |     |

| THERMAL RESISTANCE RATINGS                  |              |                    |         |         |        |  |
|---|--------------|--------------------|---------|---------|--------|--|
| Parameter                                   |              | Symbol             | Typical | Maximum | Unit   |  |
| Maximum Junction-to-Ambient <sup>a, c</sup> | t ≤ 10 s     | R <sub>thJA</sub>  | 38      | 46      | °C/W   |  |
| Maximum Junction-to-Foot                    | Steady State | R <sub>th.IF</sub> | 20      | 25      | - C/VV |  |

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under Steady State conditions is 85 °C/W.
- d. Based on  $T_C$  = 25 °C.



| Parameter                                     | Symbol                            | Test Conditions   | Min.  | Тур.   | Max.  | Unit |
|---|-----------------------------------|---|-------|--------|-------|------|
| Static  |                                   |   |       |        |       |      |
| Drain-Source Breakdown Voltage                | $V_{DS}$                          | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$  | - 30  |        |       | V    |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$             | I <sub>D</sub> = - 250 μA   |       | - 34   |       | mV/  |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$           | η = - 230 μΑ  |       | 5.3    |       | °C   |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>               | $V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$   | - 1.0 |        | - 2.5 | V    |
| Gate-Source Leakage                           | I <sub>GSS</sub>                  | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$   |       |        | ± 100 | nA   |
| Zoro Coto Voltogo Droin Current               | I <sub>DSS</sub>                  | V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V   |       |        | - 1   | ,    |
| Zero Gate Voltage Drain Current               |                                   | V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C                     |       |        | - 5   | μA   |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>                | $V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$  | - 30  |        |       | Α    |
| D : 0   | В                                 | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 10 A   |       | 0.033  |       |      |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>               | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 8 A   |       | 0.046  |       | Ω    |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>                   | V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 10 A   |       | 28     |       | S    |
| Dynamic <sup>b</sup>                          |                                   |   |       |        |       |      |
| Input Capacitance                             | C <sub>iss</sub>                  |   |       | 1350   |       | pF   |
| Output Capacitance                            | C <sub>oss</sub>                  | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                           |       | 255    |       |      |
| Reverse Transfer Capacitance                  | $C_{rss}$                         |   |       | 190    |       |      |
| T. 10 . 01                                    | \/_                               | $V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$                     |       | 27     | 43    |      |
| Total Gate Charge                             | $Q_g$                             |   |       | 19     | 25    |      |
| Gate-Source Charge                            | $Q_gs$                            | $V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$                    |       | 6      |       | nC   |
| Gate-Drain Charge                             | $Q_{gd}$                          |   |       | 12     |       |      |
| Gate Resistance                               | R <sub>q</sub>                    | f = 1 MHz   | 0.5   | 2.2    | 4.4   | Ω    |
| Turn-On Delay Time                            | t <sub>d(on)</sub>                |   |       | 13     | 25    |      |
| Rise Time                                     | t <sub>r</sub>                    | $V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$  |       | 12     | 24    | 1    |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>               | $I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 Ω   |       | 40     | 70    |      |
| Fall Time                                     | t <sub>f</sub>                    | 1   |       | 9      | 18    |      |
| Turn-On Delay Time                            | t <sub>d(on)</sub>                |   |       | 48     | 80    | ns   |
| Rise Time                                     | t <sub>r</sub>                    | $V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$  |       | 92     | 160   |      |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>               | $I_{D} \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_{g} = 1 \Omega$                     |       | 34     | 60    |      |
| Fall Time                                     | t <sub>f</sub>                    | ]   |       | 19     | 35    |      |
| Drain-Source Body Diode Characteris           | stics                             |   |       |        |       |      |
| Continous Source-Drain Diode Current          | I <sub>S</sub>                    | T <sub>C</sub> = 25 °C  |       |        | - 4.1 | ^    |
| Pulse Diode Forward Current                   | I <sub>SM</sub>                   | -   |       |        | - 40  | Α    |
| Body Diode Voltage                            | V <sub>SD</sub>                   | I <sub>S</sub> = - 3 A, V <sub>GS</sub> = 0 V   |       | - 0.75 | - 1.2 | V    |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>                   |   |       | 27     | 45    | ns   |
| Body Diode Reverse Recovery Charge            | v Diode Reverse Recovery Charge O |   |       | 16     | 27    | nC   |
| Reverse Recovery Fall Time                    | t <sub>a</sub>                    | $I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ |       | 12     |       | ns   |
| Reverse Recovery Rise Time                    | t <sub>b</sub>                    | 1   |       | 15     |       |      |

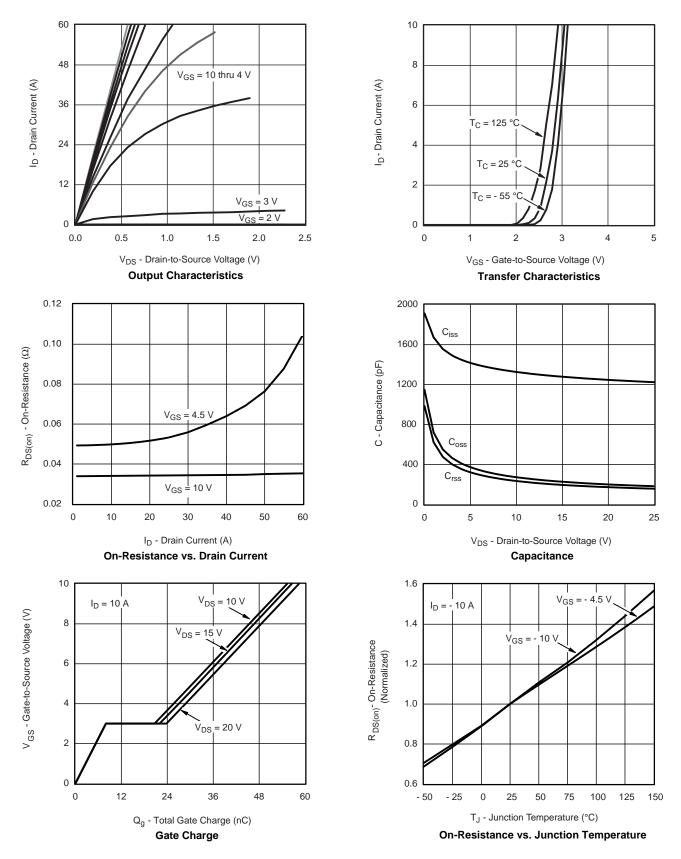
#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

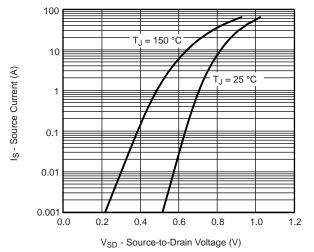


## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

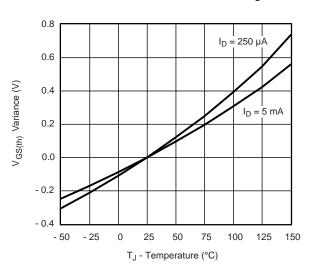




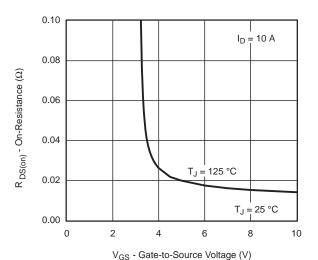
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Source-Drain Diode Forward Voltage



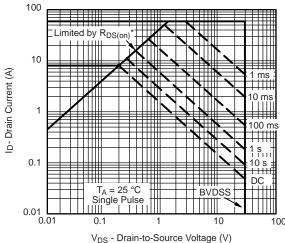
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

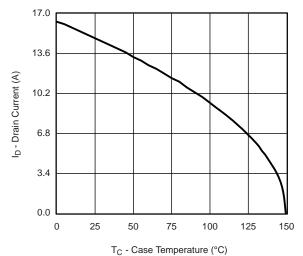


\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

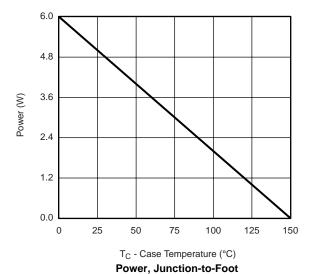
Safe Operating Area

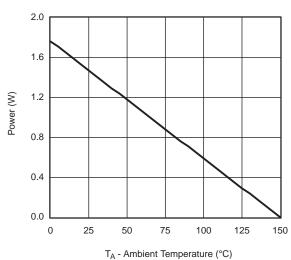


# MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



# **Current Derating\***



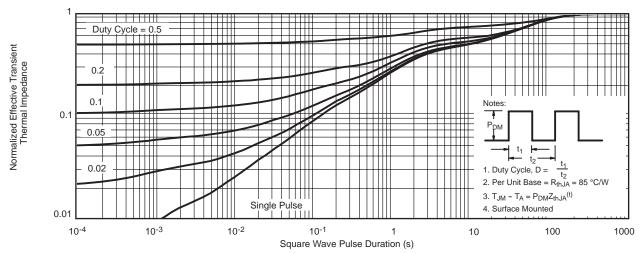


Power Derating, Junction-to-Ambient

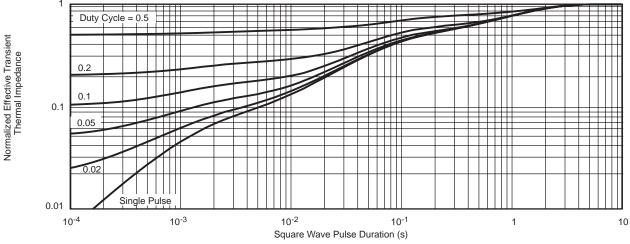
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package



## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



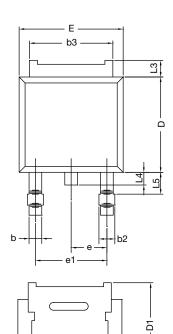
Normalized Thermal Transient Impedance, Junction-to-Ambient



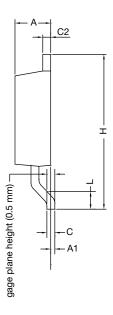
Normalized Thermal Transient Impedance, Junction-to-Foot



# **TO-252AA CASE OUTLINE**



E1



|                                 | MILLIMETERS |          | INC       | HES       |  |  |
|---------------------------------|-------------|----------|-----------|-----------|--|--|
| DIM.                            | MIN.        | MAX.     | MIN.      | MAX.      |  |  |
| Α                               | 2.18        | 2.38     | 0.086     | 0.094     |  |  |
| A1                              | -           | 0.127    | -         | 0.005     |  |  |
| b                               | 0.64        | 0.88     | 0.025     | 0.035     |  |  |
| b2                              | 0.76        | 1.14     | 0.030     | 0.045     |  |  |
| b3                              | 4.95        | 5.46     | 0.195     | 0.215     |  |  |
| С                               | 0.46        | 0.61     | 0.018     | 0.024     |  |  |
| C2                              | 0.46        | 0.89     | 0.018     | 0.035     |  |  |
| D                               | 5.97        | 6.22     | 0.235     | 0.245     |  |  |
| D1                              | 5.21        | -        | 0.205     | -         |  |  |
| Е                               | 6.35        | 6.73     | 0.250     | 0.265     |  |  |
| E1                              | 4.32        | =        | 0.170     | -         |  |  |
| Н                               | 9.40        | 10.41    | 0.370     | 0.410     |  |  |
| е                               | 2.28        | BSC      | 0.090 BSC |           |  |  |
| e1                              | 4.56        | 4.56 BSC |           | 0.180 BSC |  |  |
| L                               | 1.40        | 1.78     | 0.055     | 0.070     |  |  |
| L3                              | 0.89        | 1.27     | 0.035     | 0.050     |  |  |
| L4                              | -           | 1.02     | -         | 0.040     |  |  |
| L5                              | 1.14        | 1.52     | 0.045     | 0.060     |  |  |
| ECN: X12-0247-Rev. M, 24-Dec-12 |             |          |           |           |  |  |

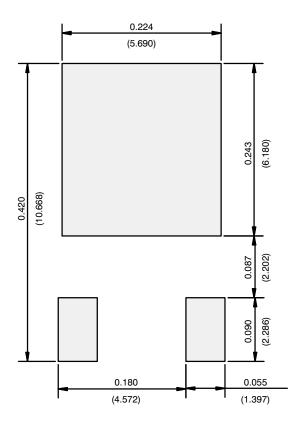
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347

#### Note

• Dimension L3 is for reference only.



# **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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